

TOSHIBA Photocoupler GaAlAs Ired & Photo-Diode Array

TLP191B

Telecommunication

Programmable Controllers

Mos Gate Driver

MOS FET Gate Driver

The TOSHIBA mini flat coupler TLP191B is a small outline coupler, suitable for surface mount assembly.

The TLP191B consists of a GaAlAs light emitting diode, optically coupled to a series connected photo diode array with shunt resistor which is suitable for MOS FET gate drive.

- Open voltage: 7.0V(min.)
- Short current: 24.0 μ A (min.)
- Isolation voltage: 2500 Vrms (min.)
- UL recognized: UL1577,file no.E67349

Absolute Maximum Ratings (Ta = 25°C)

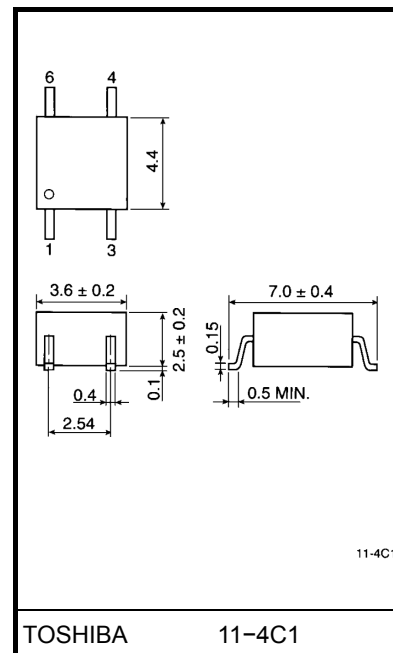
| Characteristic | | Symbol | Rating | Unit |
|--|--|-------------------------------|---------|---------|
| LED | Forward current | I_F | 50 | mA |
| | Forward current derating (Ta \geq 25°C) | $\Delta I_F / ^\circ\text{C}$ | -0.5 | mA / °C |
| | Pulse forward current (100 μ s pulse, 100 pps) | I_{FP} | 1 | A |
| | Reverse voltage | V_R | 3 | V |
| | Junction temperature | T_j | 125 | °C |
| Detector | Forward current | I_{FD} | 50 | μ A |
| | Reverse voltage | V_{RD} | 10 | V |
| | Junction temperature | T_j | 125 | °C |
| Storage temperature range | | T_{stg} | -55~125 | °C |
| Operating temperature range | | T_{opr} | -40~80 | °C |
| Lead soldering temperature (10s) | | T_{sol} | 260 | °C |
| Isolation voltage (AC, 1 min., R.H. \leq 60%) (Note) | | BV_S | 2500 | Vrms |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

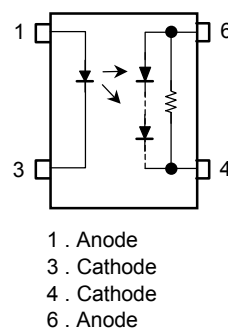
(Note) Device considered a two terminal device: Pins 1 and 3 shorted together and pins 4 and 6 shorted together.

Unit in mm



Weight: 0.09 g

Pin Configuration(top view)



Recommended Operating Conditions

| Characteristic | Symbol | Min. | Typ. | Max. | Unit |
|-----------------------|-----------|------|------|------|------|
| Forward current | I_F | — | 20 | 25 | mA |
| Operating temperature | T_{opr} | -25 | — | 85 | °C |

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Individual Electrical Characteristics ($T_a = 25^\circ\text{C}$)

| Characteristic | | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|----------------|--------------------------------|----------|----------------------------------|------|------|------|---------------|
| LED | Forward voltage | V_F | $I_F = 10\text{ mA}$ | 1.2 | 1.4 | 1.7 | V |
| | Reverse current | I_R | $V_R = 3\text{ V}$ | — | — | 10 | μA |
| | Capacitance | C_T | $V = 0, f = 1\text{ MHz}$ | — | 30 | 60 | pF |
| Detector | Forward voltage | V_{FD} | $I_{FD} = 10\text{ }\mu\text{A}$ | — | 7 | — | V |
| | Reverse current | I_{RD} | $V_{RD} = 10\text{ V}$ | — | 7 | — | μA |
| | Capacitance (anode to cathode) | C_{TD} | $V = 0, f = 1\text{ MHz}$ | — | — | — | pF |

Coupled Electrical Characteristics ($T_a = 25^\circ\text{C}$)

| Characteristic | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|----------------|----------|----------------------|------|------|------|---------------|
| Open voltage | V_{OC} | $I_F = 20\text{ mA}$ | 7 | 8 | — | V |
| Short current | I_{SC} | $I_F = 20\text{ mA}$ | 24 | 40 | — | μA |

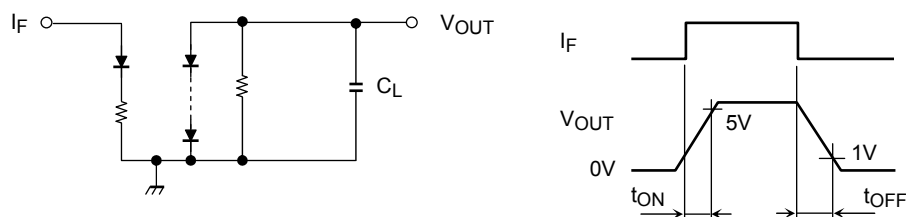
Isolation Characteristics ($T_a = 25^\circ\text{C}$)

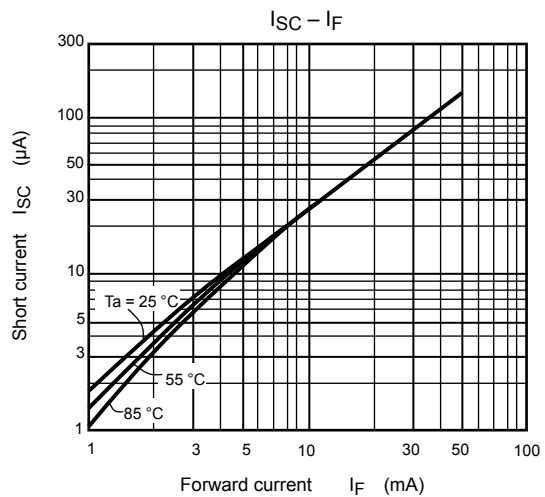
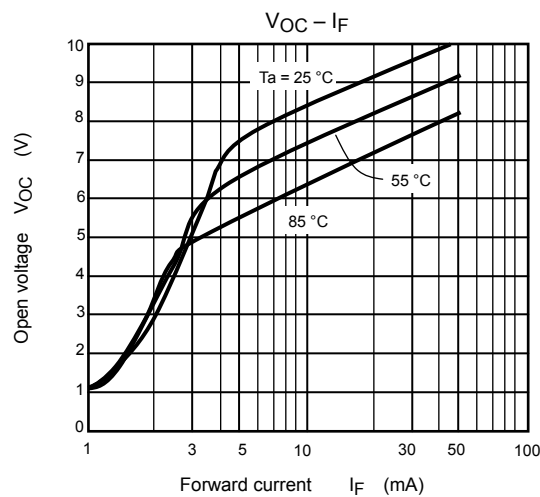
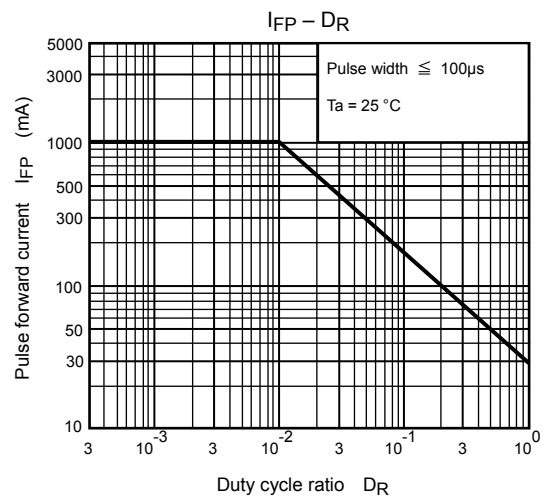
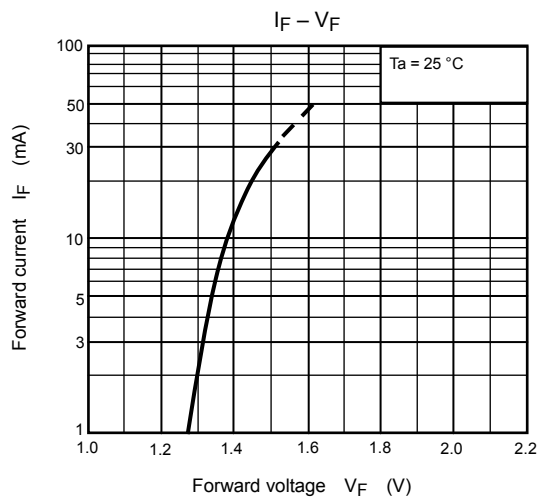
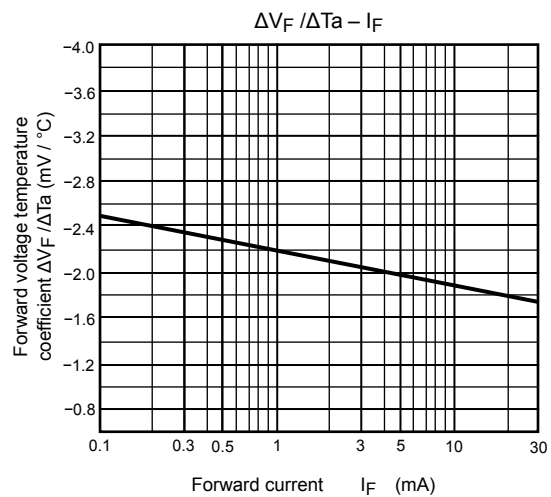
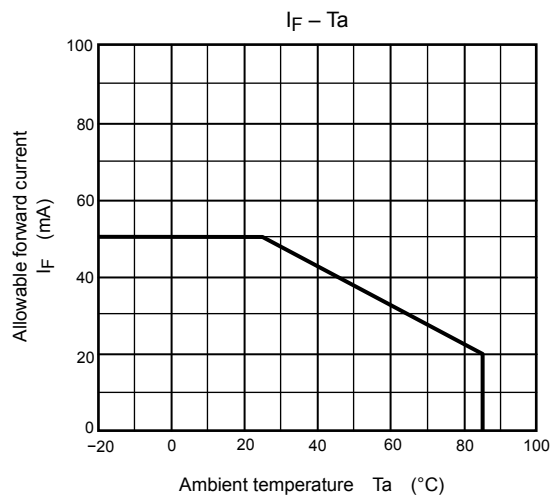
| Characteristic | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|-----------------------------|--------|---|--------------------|-----------|------|-----------|
| Capacitance input to output | C_S | $V_S = 0, f = 1\text{ MHz}$ | — | 0.8 | — | pF |
| Isolation resistance | R_S | $V_S = 500\text{ V}, \text{R.H.} \leq 60\%$ | 5×10^{10} | 10^{14} | — | Ω |
| Isolation voltage | BV_S | AC, 1 minute | 2500 | — | — | V_{rms} |
| | | AC, 1 second in oil | — | 5000 | — | |
| | | DC, 1 minute in oil | — | 5000 | — | Vdc |

Switching Characteristics ($T_a = 25^\circ\text{C}$)

| Characteristic | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|----------------|-----------|---|------|------|------|------|
| Turn-on time | t_{ON} | $I_F = 20\text{ mA}, C_L = 1000\text{ pF}$ (Fig.1) | — | 0.2 | — | ms |
| Turn-off time | t_{OFF} | | — | 3 | — | ms |

Fig. 1 Switching time test circuit





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20070701-EN

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